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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(use as many sheets as necessary)

Sheet	1	of	2

Complete if Known	
Application Number	10/065,209
Filing Date	9/25/2002
First Named Inventor	Longden et al.
Art Unit	TBA
Examiner Name	TBA
Attorney Docket Number	73591

FOREIGN PATENT DOCUMENTS

Examiner Initials*	Cite No.[1]	Foreign Patent Document: Country Code[3] - Number[4] - Kind Code[5] (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T[6]
bf		FR 2584 863	01-16-1987			
		EP 0160 327	11-06-1985			
		JP 56 103452	08-18-1981			
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bf		JP 2 278740	11-15-1990			

Examiner Signature		Date Considered	3/30/06

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[3]Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). [4]For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. [5]Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. [6]Applicant is to place a check mark here if English language Translation is attached.
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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Sheet 2 of 2

Complete if Known	
Application Number	10/065,209
Filing Date	9/25/2002
First Named Inventor	Longden et al.
Group Art Unit	TBA
Examiner Name	TBA
Attorney Docket Number	73591

OTHER PRIOR ART -- NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No.[1]	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T[2]
DF		"Electronics Packaging and Production", p 26-27	
		Electronic Materials and Processes, Consulting and Short Courses:, p 1-3	
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DF		C. Harper, "Electronic Packaging and Interconnection Handbook", McGraw Hill 1997, p 6.34	

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Electronic Information Disclosure Statement

Method and apparatus for shielding an integrated circuit from radiation

Application:	*10/065209*
	10/065209
Confirmation:	8169
Applicant(s):	Larry Longden
Docket Number:	73591
Group Art Unit:	2878
Examiner:	Unknown
search string:	(5001528 or 5006479 or 5024965 or 5047260 or 5096851 or 5138430 or 5139969 or 5140390 or 5149662 or 5151770 or 5166772 or 5180513 or 5202536 or 5206794 or 5220192 or 5239126 or 5250845 or 5268331 or 5294826 or 5304750 or 5317107 or 5324952 or 5384477 or 5406117 or 5422435 or 5424251 or 5426566 or 5436411 or 5441900 or 5495394 or 5495398 or 5502289 or 5527742 or 5552338 or 5561265 or 5577319 or 5578526 or 5589129 or 5610443 or 5635754 or 5672918 or 5706840 or 5714102 or 5770304 or 5780163 or 5824568 or 5825042 or 5828425 or 5851852).pn.

US Patent Documents

Note: Applicant is not required to submit a paper copy of cited US Patent Documents

init	Citation No.	Patent Number	Date	Bar Code	Patentee	Class	Subclass
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	P02	5006479	1991-04-09	*5006479*	Brandewie		
	P03	5024965	1991-06-18	*5024965*	Chang et al.		
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Examiner Name	Date
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DC	P15	6455864	2002-09-24	*6455864*	Featherby et al.

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[signature]	3/30/06

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Sheet 1 of 1

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Filing Date	09/25/2002
First Named Inventor	Larry L. Longden
Group Art Unit	2814
Examiner Name	Farahani
Attorney Docket Number	026471-4101

U.S. PATENT DOCUMENTS

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DF	A1	4922754		Horne et al.	05-08-1990	
DF	A2	5992237		McCarty et al.	11-30-1999	

FOREIGN PATENT DOCUMENTS

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NON PATENT LITERATURE DOCUMENTS

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	A3	International Search Report for international application No. PCT/US03/30245	

Examiner Signature		Date Considered	3/30/06

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